

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Koji Hayashi et al. Art Unit : 2627
Serial No. : 09/748,509 Examiner : Kim Kwok Chu
Filed : December 26, 2000
Title : CONTROLLER FOR DATA RECORDER

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed after a first Office action on the merits, but before receipt of a final Office action or a Notice of Allowance. The fee in the amount of \$180.00 for the late submission fee of §1.17(p) is being paid concurrently herewith on the Electronic Filing System (EFS) by way of Deposit Account authorization. Please apply all charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: May 24, 2006



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| Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b)) | U.S. Department of Commerce Patent and Trademark Office | Attorney's Docket No. 10449-030001 | Application No. 09/748,509 |
| | Applicant Koji Hayashi et al. | | |
| | Filing Date December 26, 2000 | Group Art Unit 2627 | |

| U.S. Patent Documents | | | | | | | |
|-----------------------|-----------|-----------------|------------------|--------------|-------|----------|----------------------------|
| Examiner Initial | Desig. ID | Document Number | Publication Date | Patentee | Class | Subclass | Filing Date If Appropriate |
| | AA | 6,775,216 | 08/10/04 | Kelly et al. | | | |
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| Foreign Patent Documents or Published Foreign Patent Applications | | | | | | | | |
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| Examiner Initial | Desig. ID | Document Number | Publication Date | Country or Patent Office | Class | Subclass | Translation | |
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| Other Documents (include Author, Title, Date, and Place of Publication) | | |
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| Examiner Signature | Date Considered |
| EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | |